TOSHIBA

TENTATIVE

TOSHIBA TRANSISTOR SILICON NPN EPITAXIAL PLANAR TYPE

2 S C 5 3 2 1

VHF~UHF BAND LOW NOISE AMPLIFIER APPLICATIONS

Low Noise Figure: NF = 1.4 dB (f = 2 GHz): $|S_{21e}|^2 = 10 \, dB \, (f = 2 \, GHz)$ High Gain

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Collector-Base Voltage	v_{CBO}	8	V
Collector-Emitter Voltage	v_{CEO}	5	V
Emitter-Base Voltage	$V_{ m EBO}$	1.5	V
Collector Current	$I_{\mathbf{C}}$	10	mA
Base Current	$I_{\mathbf{B}}$	5	mA
Collector Power Dissipation	$P_{\mathbf{C}}$	100	mW
Junction Temperature	T_{j}	125	°C
Storage Temperature Range	$\mathrm{T_{stg}}$	-55~125	°C

MARKING



MICROWAVE CHARACTERISTICS (Ta = 25°C)

 2.1 ± 0.1 1.25 ± 0.1 +0.1 BASE **EMITTER** COLLECTOR **JEDEC** SC-70 **EIAJ**

Unit in mm

TOSHIBA	2-2E1A
Weight: 0.0	06 g

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Transition Frequency	${ m f_T}$	$V_{CE} = 3 V$, $I_{C} = 7 mA$	9	_	_	GHz
Incortion (-ain	$ S_{21e} ^2(1)$	$V_{CE} = 3 V$, $I_{C} = 7 mA$, $f = 1 GHz$	12.5	15.5	_	dB
	$ S_{21e} ^2$ (2)	$V_{CE} = 3 V$, $I_{C} = 7 mA$, $f = 2 GHz$	7	10	_	ub
Noise Kigure	NF (1)	$V_{CE} = 3 \text{ V}, I_{C} = 3 \text{ mA}, f = 1 \text{ GHz}$	_	0.9	1.8	dB
	NF (2)	$V_{CE} = 3 V, I_{C} = 3 mA, f = 2 GHz$	_	1.4	2.2	լ աթ

ELECTRICAL CHARACTERISTICS ($Ta = 25^{\circ}C$)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Collector Cut-off Current	I_{CBO}	$V_{CB} = 8 V, I_{E} = 0$		_	1	μ A
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 1 V, I_C = 0$	_	_	1	μ A
DC Current Gain	$_{ m h_{FE}}$	$V_{CE} = 3 V, I_{C} = 7 mA$	50	_	250	V
Output Capacitance	$C_{\mathbf{ob}}$	$V_{CB} = 2.5 V, I_{E} = 0,$	_	0.4	_	pF
Reverse Transfer Capacitance	$\mathrm{C_{re}}$	f = 1 MHz (Note)	_	0.3	0.7	pF

(Note): C_{re} is measured by 3 terminal method with Capacitance bridge.

CAUTION

This device electrostatic sensitivity. Please handle with caution.

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